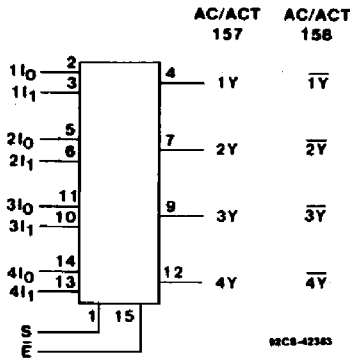




Data sheet acquired from Harris Semiconductor  
SCHS283

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158



FUNCTIONAL DIAGRAM

## Quad 2-Input Multiplexers

AC/ACT157 - Non-Inverting

AC/ACT158 - Inverting

### Type Features:

- Buffered inputs
- Typical propagation delay (AC/ACT158):  
3.8 ns @  $V_{CC} = 5V, T_A = 25^\circ C, C_L = 50 pF$

The RCA CD54/74AC157, -158 and CD54/74ACT157, -158 quad 2-input multiplexers use the RCA ADVANCED CMOS technology. Both circuits can select four bits of data from two sources under the control of a common select input (S). The Enable input ( $\bar{E}$ ) is active LOW. When  $\bar{E}$  is HIGH, all of the outputs of the 158 are forced HIGH and in the 157, all of the outputs are forced LOW, regardless of all other input conditions.

The CD74AC/ACT157 and CD74AC/ACT158 are supplied in 16-lead dual-in-line plastic packages (E suffix) and in 16-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to 70°C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 to +125°C).

The CD54AC157, -158 and CD54ACT157, -158, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

### Family Features:

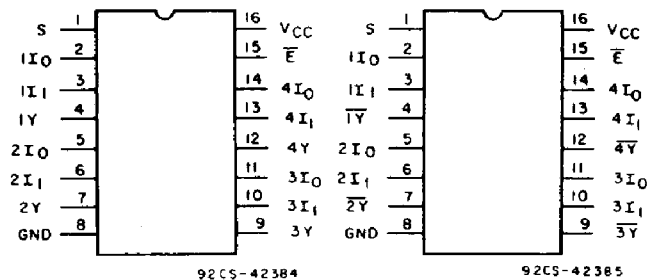
- Exceeds 2-kV ESD Protection - MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST®/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply.
- ±24-mA output drive current
  - Fanout to 15 FAST® ICs
  - Drives 50-ohm transmission lines

®FAST is a Registered Trademark of Fairchild Semiconductor Corp.

TRUTH TABLE

Enable	Select Input	Data Inputs		Output	
				157	158
$\bar{E}$	S	$I_0$	$I_1$	Y	$\bar{Y}$
H	X	X	X	L	H
L	L	L	X	L	H
L	L	H	X	H	L
L	H	X	L	L	H
L	H	X	H	H	L

H = High level, L = Low level, X = Don't care



CD54/74AC/ACT157

CD54/74AC/ACT158

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This data sheet is applicable to the CD54/74AC157 and CD74AC158. The CD54AC158, CD54ACT157, and CD54ACT158 were not acquired from Harris Semiconductor. See SCHS238 for information on the CD74ACT157 and CD74ACT158.

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158

**MAXIMUM RATINGS, Absolute-Maximum Values:**

DC SUPPLY-VOLTAGE ( $V_{CC}$ )	-0.5 to 6 V
DC INPUT DIODE CURRENT, $I_{IK}$ (for $V_i < -0.5$ V or $V_i > V_{CC} + 0.5$ V)	$\pm 20$ mA
DC OUTPUT DIODE CURRENT, $I_{OK}$ (for $V_o < -0.5$ V or $V_o > V_{CC} + 0.5$ V)	$\pm 50$ mA
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, $I_o$ (for $V_o > -0.5$ V or $V_o < V_{CC} + 0.5$ V)	$\pm 50$ mA
DC $V_{CC}$ or GROUND CURRENT ( $I_{CC}$ or $I_{GND}$ )	$\pm 100$ mA*
POWER DISSIPATION PER PACKAGE ( $P_D$ ):	
For $T_A = -55$ to $+100^\circ\text{C}$ (PACKAGE TYPE E)	500 mW
For $T_A = +100$ to $+125^\circ\text{C}$ (PACKAGE TYPE E)	Derate Linearly at 8 mW/ $^\circ\text{C}$ to 300 mW
For $T_A = -55$ to $+70^\circ\text{C}$ (PACKAGE TYPE M)	400 mW
For $T_A = +70$ to $+125^\circ\text{C}$ (PACKAGE TYPE M)	Derate Linearly at 6 mW/ $^\circ\text{C}$ to 70 mW
OPERATING-TEMPERATURE RANGE ( $T_A$ )	$-55$ to $+125^\circ\text{C}$
STORAGE TEMPERATURE ( $T_{stg}$ )	$-65$ to $+150^\circ\text{C}$
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ in. ( $1.59 \pm 0.79$ mm) from case for 10 s maximum	$+265^\circ\text{C}$
Unit inserted into PC board min. thickness $1/16$ in. ( $1.59$ mm) with solder contacting lead tips only	$+300^\circ\text{C}$

\* For up to 4 outputs per device; add  $\pm 25$  mA for each additional output.

**RECOMMENDED OPERATING CONDITIONS:**

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range, $V_{CC}$ *: (For $T_A =$ Full Package-Temperature Range) AC Types ACT Types	1.5 4.5	5.5 5.5	V V
DC Input or Output Voltage, $V_i, V_o$	0	$V_{CC}$	V
Operating Temperature, $T_A$	-55	+125	$^\circ\text{C}$
Input Rise and Fall Slew Rate, $dt/dv$ at 1.5 V to 3 V (AC Types) at 3.6 V to 5.5 V (AC Types) at 4.5 V to 5.5 V (ACT Types)	0 0 0	50 20 10	ns/V ns/V ns/V

\*Unless otherwise specified, all voltages are referenced to ground.

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158

STATIC ELECTRICAL CHARACTERISTICS: AC Series

CHARACTERISTICS	TEST CONDITIONS		V <sub>CC</sub> (V)	AMBIENT TEMPERATURE (T <sub>A</sub> ) - °C						UNITS	
				+25		-40 to +85		-55 to +125			
	V <sub>I</sub> (V)	I <sub>O</sub> (mA)		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
High-Level Input Voltage V <sub>IH</sub>			1.5	1.2	—	1.2	—	1.2	—	V	
			3	2.1	—	2.1	—	2.1	—		
			5.5	3.85	—	3.85	—	3.85	—		
Low-Level Input Voltage V <sub>IL</sub>			1.5	—	0.3	—	0.3	—	0.3	V	
			3	—	0.9	—	0.9	—	0.9		
			5.5	—	1.65	—	1.65	—	1.65		
High-Level Output Voltage V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	#, * {	-0.05	1.5	1.4	—	1.4	—	1.4	—	V
			-0.05	3	2.9	—	2.9	—	2.9	—	
			-0.05	4.5	4.4	—	4.4	—	4.4	—	
			-4	3	2.58	—	2.48	—	2.4	—	
			-24	4.5	3.94	—	3.8	—	3.7	—	
			-50	5.5	—	—	3.85	—	—	—	
Low Level Output Voltage V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	#, * {	0.05	1.5	—	0.1	—	0.1	—	0.1	V
			0.05	3	—	0.1	—	0.1	—	0.1	
			0.05	4.5	—	0.1	—	0.1	—	0.1	
			12	3	—	0.36	—	0.44	—	0.5	
			24	4.5	—	0.36	—	0.44	—	0.5	
			75	5.5	—	—	—	1.65	—	—	
Input Leakage Current I <sub>I</sub>	V <sub>CC</sub> or GND		5.5	—	±0.1	—	±1	—	±1	μA	
Quiescent Supply Current, MSI I <sub>CC</sub>	V <sub>CC</sub> or GND	0	5.5	—	8	—	80	—	160	μA	

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

\*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158

## STATIC ELECTRICAL CHARACTERISTICS: ACT Series

CHARACTERISTICS	TEST CONDITIONS	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C						UNITS		
			+25		-40 to +85		-55 to +125				
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.			
High-Level Input Voltage	$V_{IH}$		4.5 to 5.5	2	—	2	—	2	—	V	
Low-Level Input Voltage	$V_{IL}$		4.5 to 5.5	—	0.8	—	0.8	—	0.8	V	
High-Level Output Voltage	$V_{OH}$	$V_{IH}$ or $V_{IL}$ #, *	-0.05	4.5	4.4	—	4.4	—	4.4	—	V
			-24	4.5	3.94	—	3.8	—	3.7	—	
			-75	5.5	—	—	3.85	—	—	—	
			-50	5.5	—	—	—	—	3.85	—	
Low-Level Output Voltage	$V_{OL}$	$V_{IH}$ or $V_{IL}$ #, *	0.05	4.5	—	0.1	—	0.1	—	0.1	V
			24	4.5	—	0.36	—	0.44	—	0.5	
			75	5.5	—	—	—	1.65	—	—	
			50	5.5	—	—	—	—	—	1.65	
Input Leakage Current	$I_I$	$V_{CC}$ or GND	5.5	—	±0.1	—	±1	—	±1	μA	
Quiescent Supply Current, MSI	$I_{CC}$	$V_{CC}$ or GND	0	5.5	—	8	—	80	—	160	μA
Additional Quiescent Supply Current per Input Pin TTL Inputs High 1 Unit Load	$\Delta I_{CC}$	$V_{CC}-2.1$	4.5 to 5.5	—	2.4	—	2.8	—	3	mA	

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

\* Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

### ACT INPUT LOADING TABLE

INPUT	UNIT LOAD*	
	157	158
I (All)	0.37	0.37
$\bar{E}$	0.83	0.83
S	1.33	1.33

\*Unit load is  $\Delta I_{CC}$  limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158

SWITCHING CHARACTERISTICS: AC Series;  $t_r, t_f = 3 \text{ ns}$ ,  $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C				UNITS
			-40 to +85		-55 to +125		
			MIN.	MAX.	MIN.	MAX.	
Propagation Delays: Data to Output	(157) $t_{PLH}$ $t_{PHL}$	1.5	—	97	—	106	ns
		3.3* 5†	3.2 2.2	10.8 7.7	3 2.1	11.9 8.5	
Enable to Output	(157) $t_{PLH}$ $t_{PHL}$	1.5	—	154	—	169	ns
		3.3 5	5.1 3.6	17.2 12.3	4.7 3.4	18.9 13.5	
Select to Output	(157) $t_{PLH}$ $t_{PHL}$	1.5	—	164	—	180	ns
		3.3 5	5.4 3.8	18.5 13.2	5.1 3.6	20.3 14.5	
Data to Output	(158) $t_{PLH}$ $t_{PHL}$	1.5	—	91	—	100	ns
		3.3 5	3 2.2	12.8 7.3	2.8 2	11.2 8	
Enable to Output	(158) $t_{PLH}$ $t_{PHL}$	1.5	—	135	—	149	ns
		3.3 5	4.5 3.2	15.2 10.8	4.2 3	16.7 11.9	
Select to Output	(158) $t_{PLH}$ $t_{PHL}$	1.5	—	147	—	161	ns
		3.3 5	4.9 3.5	16.5 11.7	4.5 3.2	18.1 12.9	
Power Dissipation Capacitance	(157) (158) $C_{PD\&}$	—	156 Typ. 149 Typ.		156 Typ. 149 Typ.		pF
Input Capacitance	$C_i$	—	—	10	—	10	pF

SWITCHING CHARACTERISTICS: ACT Series;  $t_r, t_f = 3 \text{ ns}$ ,  $C_L = 50 \text{ pF}$

CHARACTERISTICS	SYMBOL	$V_{CC}$ (V)	AMBIENT TEMPERATURE ( $T_A$ ) - °C				UNITS
			-40 to +85		-55 to +125		
			MIN.	MAX.	MIN.	MAX.	
Propagation Delays: Data to Output	(157) $t_{PLH}$ $t_{PHL}$	5†	2.5	8.6	2.4	9.5	ns
Enable to Output	(157) $t_{PLH}$ $t_{PHL}$	5	3.6	12.3	3.4	13.5	ns
Select to Output	(157) $t_{PLH}$ $t_{PHL}$	5	3.8	13.2	3.6	14.5	ns
Data to Output	(158) $t_{PLH}$ $t_{PHL}$	5	2.4	8.4	2.3	9.2	ns
Enable to Output	(158) $t_{PLH}$ $t_{PHL}$	5	3.3	11.3	3.1	12.4	ns
Select to Output	(158) $t_{PLH}$ $t_{PHL}$	5	3.6	12.3	3.4	13.5	ns
Power Dissipation Capacitance	(157) (158) $C_{PD\&}$	—	156 Typ. 149 Typ.		156 Typ. 149 Typ.		pF
Input Capacitance	$C_i$	—	—	10	—	10	pF

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\*3.3 V: min. is @ 3.6 V  
max. is @ 3 V

†5 V: min. is @ 5.5 V  
max. is @ 4.5 V

$\&C_{PD}$  is used to determine the dynamic power consumption, per function.

For AC Series,  $P_D = C_{PD}V_{CC}^2 f_i + \Sigma(C_L V_{CC}^2 f_o)$

For ACT Series,  $P_D = C_{PD}V_{CC}^2 f_i + \Sigma(C_L V_{CC}^2 f_o) + V_{CC} \Delta I_{CC}$

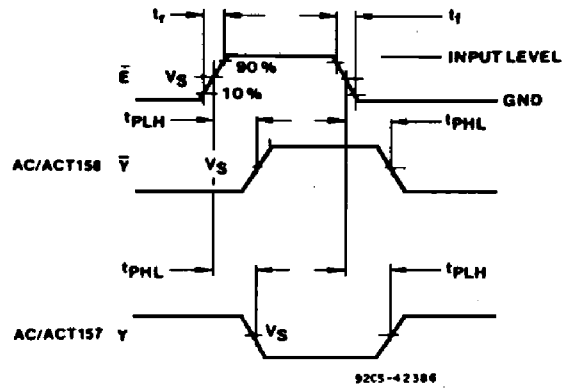
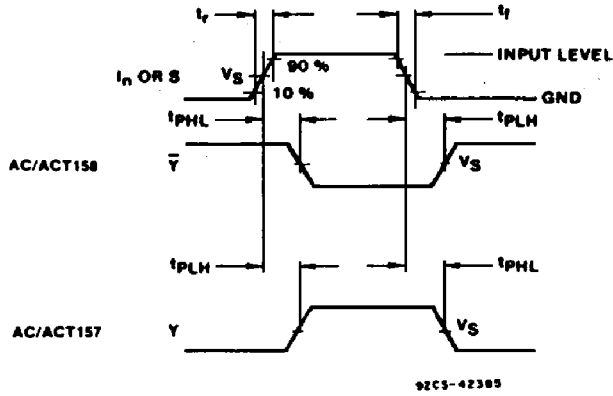
where  $f_i$  = input frequency

$f_o$  = output frequency

$C_L$  = output load capacitance

$V_{CC}$  = supply voltage.

# CD54/74AC157, CD54/74AC158 CD54/74ACT157, CD54/74ACT158



	CD54/74AC	CD54/74ACT
Input Level	$V_{CC}$	3 V
Input Switching Voltage, $V_S$	$0.5 V_{CC}$	1.5 V
Output Switching Voltage, $V_S$	$0.5 V_{CC}$	$0.5 V_{CC}$

Fig. 3 - Inputs or select to output propagation delays.

Fig. 4 -  $\bar{E}$ enable to output propagation delays.

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